

<b>INFORMATION DISCLOSURE CITATION IN AN APPLICATION</b> <small>(Use several sheets if necessary)</small>				Attorney Docket No.: <b>8074-1041</b>	Application No.: <b>NEW NATIONAL PHASE</b>		
				Applicant: <b>Minoru ASOGAWA et al.</b>			
				Filing Date: <b>May 27, 2005</b>	Group Art Unit:		
<b>U.S. PATENT DOCUMENTS</b>							
Examiner Initial	Document Number	Date	Name		Class	Subclass	Filing date (if appropriate)
/BS/	5,593,565	1/14/1997	ARMAND AJDARIAj				
/BS/	6,027,623	2/22/2000	OHKAWA				
<b>FOREIGN PATENT DOCUMENTS</b>							
Examiner Initial	Document Number	Date	Country		Class	Subclass	Translation
/BS/	2002-532715	10/2/2002	JAPAN				
	9-504362	4/28/1997	JAPAN				
/BS/	2004-217	1/8/2004	JAPAN				
/BS/	2002-131280	5/9/2002	JAPAN				
<b>OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)</b>							
/BS/	SANO, BABA, IGUCHI, IIDA, KAWAURA, SAKAMOTO, Dai 63 Kai Extended Abstracts; The Japan Society of Applied Physics, separate Vol. 3, 24 September, 2002 (24-09-02), page 1146 (25a-R-8)						
/BS/	M.Baba, T. Sano, N. Iguchi, K. Iida, T. Sakamoto, H. Kawaura, Sixth International Conference on Miniaturized Chemical and Biochemical Analysis Systems (Micro Total Analysis Systems 2002), 03 November, 2002 (03-11-02), Vol. 2, pages 763 to 765						
EXAMINER: /Bernard Souw/			DATE CONSIDERED 05/02/2007				
<b>EXAMINER:</b> Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.							

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.

\* English language abstract provided for the Examiner's convenience

УГ

Y&T May 27, 2005